# Ignition IGBT 18 Amps, 400 Volts

# **N-Channel DPAK**

This Logic Level Insulated Gate Bipolar Transistor (IGBT) features monolithic circuitry integrating ESD and Over–Voltage clamped protection for use in inductive coil drivers applications. Primary uses include Ignition, Direct Fuel Injection, or wherever high voltage and high current switching is required.

#### Features

- Ideal for Coil-on-Plug Applications
- DPAK Package Offers Smaller Footprint for Increased Board Space
- Gate-Emitter ESD Protection
- Temperature Compensated Gate-Collector Voltage Clamp Limits Stress Applied to Load
- Integrated ESD Diode Protection
- New Design Increases Unclamped Inductive Switching (UIS) Energy Per Area
- Low Threshold Voltage Interfaces Power Loads to Logic or Microprocessor Devices
- Low Saturation Voltage
- High Pulsed Current Capability
- Optional Gate Resistor (R<sub>G</sub>) and Gate-Emitter Resistor (R<sub>GE</sub>)
- Emitter Ballasting for Short–Circuit Capability
- Pb-Free Package is Available\*

### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

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Rating	Symbol	Value	Unit		
Collector-Emitter Voltage	V <sub>CES</sub>	430	V <sub>DC</sub>		
Collector-Gate Voltage	V <sub>CER</sub>	430	V <sub>DC</sub>		
Gate-Emitter Voltage	V <sub>GE</sub>	18	V <sub>DC</sub>		
Collector Current–Continuous @ T <sub>C</sub> = 25°C – Pulsed	Ι <sub>C</sub>	15 50	A <sub>DC</sub> A <sub>AC</sub>		
ESD (Human Body Model) R = 1500 Ω, C = 100 pF	ESD	8.0	kV		
ESD (Machine Model) R = 0 $\Omega$ , C = 200 pF	ESD	800	V		
Total Power Dissipation @ T <sub>C</sub> = 25°C Derate above 25°C	P <sub>D</sub>	115 0.77	Watts W/°C		
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	–55 to +175	°C		

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

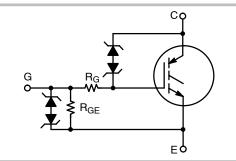
\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.



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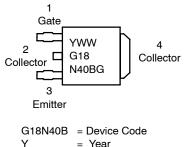
http://onsemi.com

18 AMPS 400 VOLTS V<sub>CE(on)</sub> ≤ 2.0 V @ I<sub>C</sub> = 10 A, V<sub>GE</sub> ≥ 4.5 V





#### MARKING DIAGRAM



1	- 1641
WW	= Work Week
G	= Pb-Free Device

### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NGD18N40CLBT4	DPAK	2500/Tape & Reel
NGD18N40CLBT4G	DPAK (Pb-Free)	2500/Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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## UNCLAMPED COLLECTOR-TO-EMITTER AVALANCHE CHARACTERISTICS (–55° $\leq$ $T_{J}$ $\leq$ 175°C)

Characteristic	Symbol	Value	Unit	
Single Pulse Collector-to-Emitter Avalanche Energy $V_{CC} = 50 \text{ V}, V_{GE} = 5.0 \text{ V}, \text{Pk } \text{I}_{L} = 21.1 \text{ A}, \text{L} = 1.8 \text{ mH}, \text{Star}$ $V_{CC} = 50 \text{ V}, V_{GE} = 5.0 \text{ V}, \text{Pk } \text{I}_{L} = 16.2 \text{ A}, \text{L} = 3.0 \text{ mH}, \text{Star}$ $V_{CC} = 50 \text{ V}, V_{GE} = 5.0 \text{ V}, \text{Pk } \text{I}_{L} = 18.3 \text{ A}, \text{L} = 1.8 \text{ mH}, \text{Star}$	E <sub>AS</sub>	400 400 300	mJ	
Reverse Avalanche Energy $V_{CC}$ = 100 V, $V_{GE}$ = 20 V, Pk I <sub>L</sub> = 25.8 A, L = 6.0 mH, Sta	E <sub>AS(R)</sub>	2000	mJ	
MAXIMUM SHORT-CIRCUIT TIMES (-55°C $\leq$ T_J $\leq$ 150'	°C)			
Short Circuit Withstand Time 1 (See Figure 17, 3 Pulses wit	h 10 ms Period)	t <sub>sc1</sub>	750	μs
Short Circuit Withstand Time 2 (See Figure 18, 3 Pulses wit	t <sub>sc2</sub>	5.0	ms	
THERMAL CHARACTERISTICS				
Thermal Resistance, Junction to Case		$R_{\theta JC}$	1.3	°C/W
Thermal Resistance, Junction to Ambient	DPAK (Note 1)	$R_{\thetaJA}$	95	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" fr	om case for 5 seconds	ΤL	275	°C

#### **ELECTRICAL CHARACTERISTICS**

Characteristic	Symbol	Test Conditions	Temperature	Min	Тур	Max	Unit
OFF CHARACTERISTICS				-		-	-
Collector-Emitter Clamp Voltage	BV <sub>CES</sub>	I <sub>C</sub> = 2.0 mA	$T_J = -40^{\circ}C$ to 150°C	380	395	420	V <sub>DC</sub>
		I <sub>C</sub> = 10 mA	$T_J = -40^{\circ}C$ to 150°C	390	405	430	
Zero Gate Voltage Collector Current	I <sub>CES</sub>		$T_{\rm J} = 25^{\circ}C$	-	2.0	20	$\mu A_{DC}$
		V <sub>CE</sub> = 350 V, V <sub>GE</sub> = 0 V	T <sub>J</sub> = 150°C	-	10	40*	
		GE 01	$T_J = -40^{\circ}C$	-	1.0	10	
		V <sub>CE</sub> = 15 V, V <sub>GE</sub> = 0 V	T <sub>J</sub> = 25°C	-	-	2.0	
Reverse Collector-Emitter Leakage Current	I <sub>ECS</sub>		$T_J = 25^{\circ}C$	-	0.7	1.0	mA
		$V_{CE} = -24 V$	T <sub>J</sub> = 150°C	-	12	25*	
			$T_J = -40^{\circ}C$	-	0.1	1.0	
Reverse Collector-Emitter Clamp Voltage	B <sub>VCES(R)</sub>		$T_J = 25^{\circ}C$	27	33	37	$V_{DC}$
		I <sub>C</sub> = -75 mA	$T_J = 150^{\circ}C$	30	36	40	
			$T_J = -40^{\circ}C$	25	32	35	
Gate-Emitter Clamp Voltage	BV <sub>GES</sub>	I <sub>G</sub> = 5.0 mA	T <sub>J</sub> = -40°C to 150°C	11	13	15	V <sub>DC</sub>
Gate-Emitter Leakage Current	I <sub>GES</sub>	V <sub>GE</sub> = 10 V	T <sub>J</sub> = -40°C to 150°C	384	640	700	μA <sub>DC</sub>
Gate Resistor	R <sub>G</sub>	_	$T_J = -40^{\circ}C$ to 150°C	-	70	-	Ω
Gate Emitter Resistor	R <sub>GE</sub>	-	T <sub>J</sub> = -40°C to 150°C	10	16	26	kΩ

1. When surface mounted to an FR4 board using the minimum recommended pad size. \*Maximum Value of Characteristic across Temperature Range.

#### ELECTRICAL CHARACTERISTICS (continued)

N CHARACTERISTICS (Note 2) Gate Threshold Voltage	V <sub>GE(th)</sub>		T <sub>J</sub> = 25°C				
Gate Threshold Voltage	V <sub>GE(th)</sub>		T - 25°C				
			1J = 25 C	1.1	1.4	1.9	V <sub>DC</sub>
		I <sub>C</sub> = 1.0 mA, V <sub>GE</sub> = V <sub>CE</sub>	T <sub>J</sub> = 150°C	0.75	1.0	1.4	
			$T_J = -40^{\circ}C$	1.2	1.6	2.1*	
Threshold Temperature Coefficient (Negative)	-	-	-	-	3.4	-	mV/°C
Collector-to-Emitter On-Voltage	V <sub>CE(on)</sub>		$T_{\rm J} = 25^{\circ}C$	1.0	1.4	1.6	V <sub>DC</sub>
		I <sub>C</sub> = 6.0 A, V <sub>GE</sub> = 4.0 V	T <sub>J</sub> = 150°C	0.9	1.3	1.6	
		VGE - 4.0 V	$T_J = -40^{\circ}C$	1.1	1.45	1.7*	
			$T_J = 25^{\circ}C$	1.3	1.6	1.9*	
	I <sub>C</sub> = 8.0 A, V <sub>GF</sub> = 4.0 V	I <sub>C</sub> = 8.0 A, V <sub>C</sub> = 4.0 V	T <sub>J</sub> = 150°C	1.2	1.55	1.8	
		VGE - 4.0 V	$T_J = -40^{\circ}C$	1.4	1.6	1.9*	
			$T_{\rm J} = 25^{\circ}C$	1.4	1.8	2.05	
		I <sub>C</sub> = 10 A, V <sub>GE</sub> = 4.0 V	$T_J = 150^{\circ}C$	1.4	1.8	2.0	
			$T_J = -40^{\circ}C$	1.4	1.8	2.1*	
			$T_J = 25^{\circ}C$	1.8	2.2	2.5	
		I <sub>C</sub> = 15 A, V <sub>GE</sub> = 4.0 V	T <sub>J</sub> = 150°C	2.0	2.4	2.6*	
		VGE - no v	$T_J = -40^{\circ}C$	1.7	2.1	2.5	
			$T_J = 25^{\circ}C$	1.3	1.8	2.0*	
		I <sub>C</sub> = 10 A, V <sub>GE</sub> = 4.5 V	T <sub>J</sub> = 150°C	1.3	1.75	2.0*	
		GE	$T_{J} = -40^{\circ}C$	1.4	1.8	2.0*	
		I <sub>C</sub> = 6.5 A, V <sub>GE</sub> = 3.7 V	T <sub>J</sub> = 25°C	-	-	1.65	
Forward Transconductance	gfs	$V_{CE}$ = 5.0 V, I <sub>C</sub> = 6.0 A	$T_J = -40^{\circ}C$ to 150°C	8.0	14	25	Mhos
YNAMIC CHARACTERISTICS	-	•	-		-	-	-

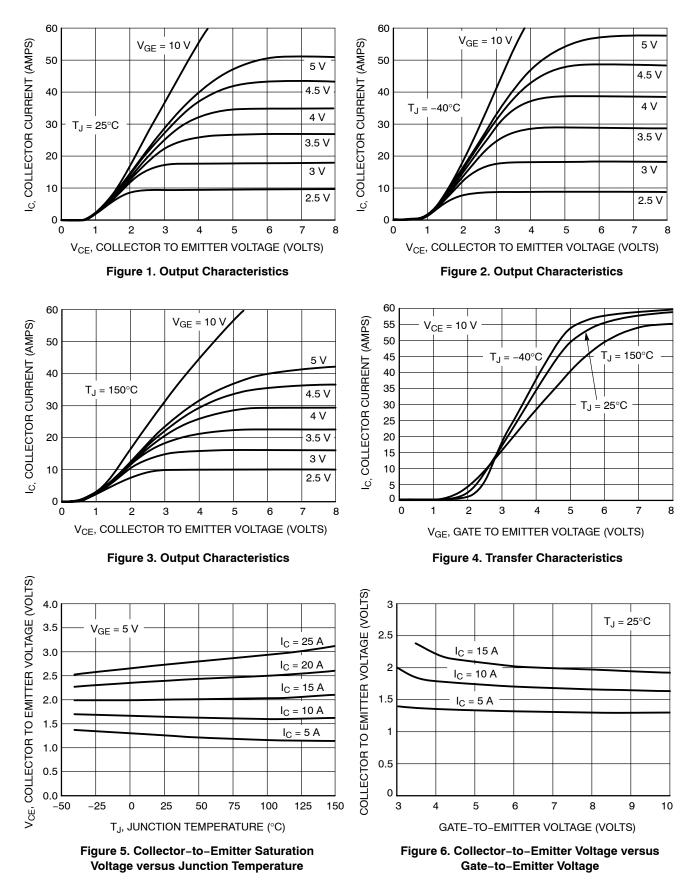
Input Capacitance	C <sub>ISS</sub>		_	400	800	1000	pF
Output Capacitance	C <sub>OSS</sub>	V <sub>CC</sub> = 25 V, V <sub>GE</sub> = 0 V f = 1.0 MHz	T <sub>J</sub> = −40°C to 150°C	50	75	100	
Transfer Capacitance	C <sub>RSS</sub>			4.0	7.0	10	

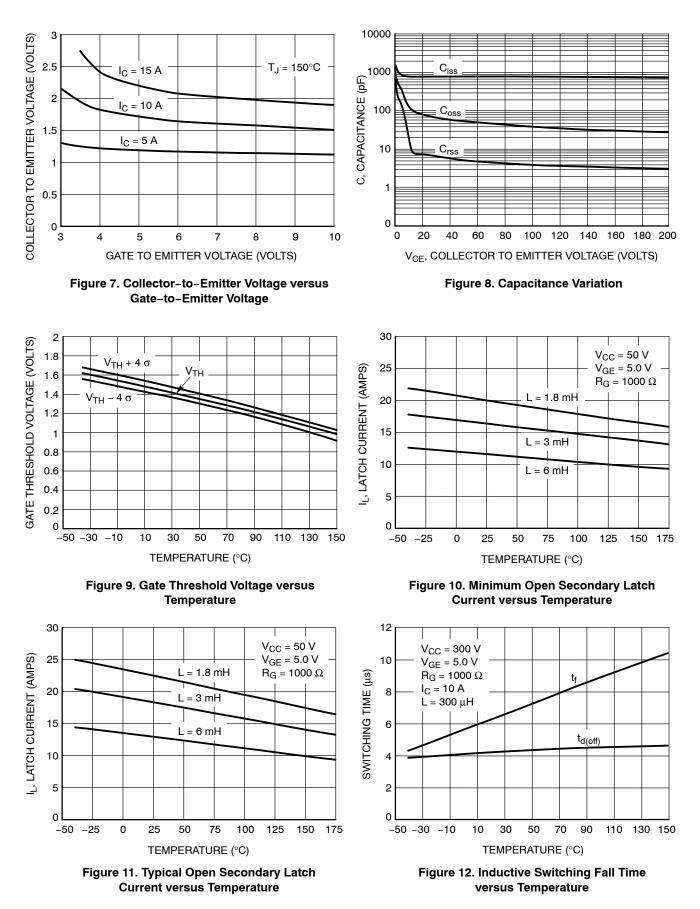
#### SWITCHING CHARACTERISTICS

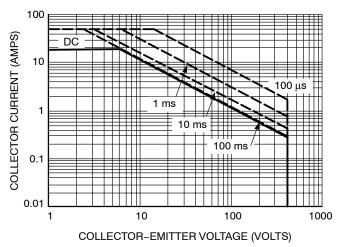
Turn-Off Delay Time (Resistive)	t <sub>d(off)</sub>		$T_J = 25^{\circ}C$	-	4.0	10	μSec
Fall Time (Resistive)	t <sub>f</sub>		$T_J = 25^{\circ}C$	-	9.0	15	
Turn-On Delay Time	t <sub>d(on)</sub>	$\label{eq:V_CC} \begin{array}{l} V_{CC} = 10 \; V, \; I_{C} = 6.5 \; A \\ R_{G} = 1.0 \; k\Omega, \; R_{L} = 1.5 \; \Omega \end{array}$	$T_J = 25^{\circ}C$	-	0.7	4.0	μSec
Rise Time	t <sub>r</sub>	$V_{CC}$ = 10 V, I <sub>C</sub> = 6.5 A R <sub>G</sub> = 1.0 kΩ, R <sub>L</sub> = 1.5 Ω	$T_J = 25^{\circ}C$	-	4.5	7.0	

2. Pulse Test: Pulse Width  $\leq$  300  $\mu$ S, Duty Cycle  $\leq$  2%. \*Maximum Value of Characteristic across Temperature Range.

#### TYPICAL ELECTRICAL CHARACTERISTICS (unless otherwise noted)









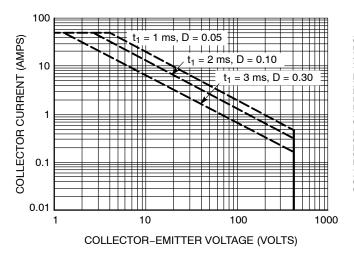
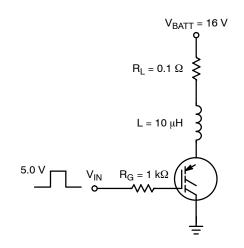


Figure 15. Pulse Train Safe Operating Area (Mounted on an Infinite Heatsink at  $T_C = 25^{\circ}C$ )





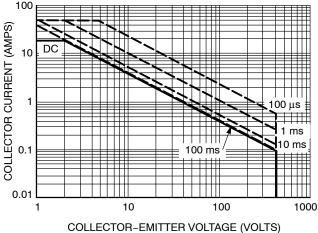


Figure 14. Single Pulse Safe Operating Area (Mounted on an Infinite Heatsink at  $T_A = 125^{\circ}C$ )

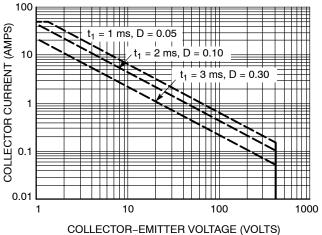


Figure 16. Pulse Train Safe Operating Area (Mounted on an Infinite Heatsink at  $T_C = 125^{\circ}C$ )

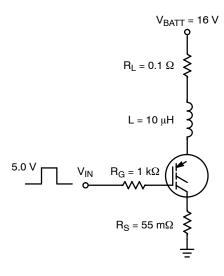


Figure 18. Circuit Configuration for Short Circuit Test #2

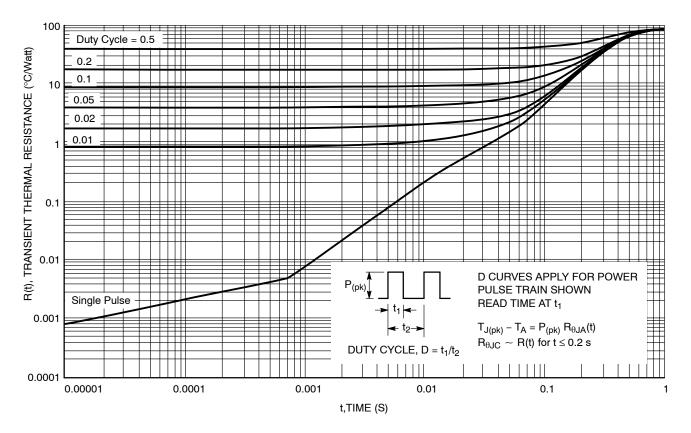
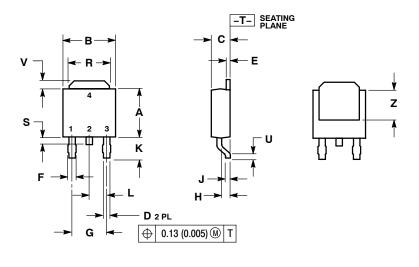


Figure 19. Transient Thermal Resistance (Non-normalized Junction-to-Ambient mounted on minimum pad area)

#### PACKAGE DIMENSIONS

DPAK CASE 369C-01 ISSUE O



NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.180	BSC	4.58	BSC
н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
ĸ	0.102	0.114	2.60	2.89
L	0.090	BSC	2.29	BSC
R	0.180	0.215	4.57	5.45
S	0.025	0.040	0.63	1.01
U	0.020		0.51	
V	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 7:

PIN 1. GATE 2. COLLECTOR

EMITTER
COLLECTOR

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